

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-3293		SERIAL NO. 11/471,106 <i>OK</i>	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Eric R. Blomiley			
				FILING DATE June 19, 2006		GROUP 1722	
U.S. PATENT DOCUMENTS							
*Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
<i>MJ</i>	AA 4,558,660	12/85	Nishizawa et al.				
	AB 5,061,872	10/91	Kulka				
	AC 5,364,667	11/94	Rhieu, Ji H.				
	AD 5,556,476	09/17/96	Lei, et al.				
	AE 5,782,974	07/1998	Sorensen et al.				
	AF 6,021,152	02/2000	Olsen et al				
	AG 6,079,426	06/2000	Subrahmanyam et al.				
	AH 8,108,490	08/2000	Lee et al.				
	AI 6,333,272	12/2001	McMillin et al.				
	AJ 6,530,894	03/2003	Mahawili				
	AK 6,994,769	02/2006	Singh, et al.				
	AL 2001/0010228	08/2001	Au et al.				
<i>MJ</i>	AM 2002/0129768	09/2002	Carpenter et al.				
FOREIGN PATENT DOCUMENTS							
Document Number	Date	Country	Class	Subclass	Translation		
					Yes	No	
AN							
AO							
AP							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
AQ							
AR							
EXAMINER <i>MJ</i>		DATE CONSIDERED 12/9/2006					
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

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<b>U.S. PATENT DOCUMENTS</b>								
*Examiner's Initials	Class	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
<i>MS</i>	AA	2003/0005858	01/2003	Rocha-Alvarez et al.				
<i>M3</i>	AB	2004/0000321	01/2004	Cui et al.				
<i>M3</i>	AC	2006/0057826	03/2006	DeBoer, Welbe				
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
	AJ							
	AK							
<b>FOREIGN PATENT DOCUMENTS</b>								
		Document Number	Date	Country	Class	Subclass	Translation	
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	AM							
	AN							
<b>OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)</b>								
	AM							
	AN							
EXAMINER <i>Mark J</i>		DATE CONSIDERED <i>12/15/2006</i>						
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